


<b>Search Notes</b> 	<b>Application/Control No.</b> 10784181	<b>Applicant(s)/Patent Under Reexamination</b> ISHII ET AL.
	<b>Examiner</b> FAWAAD HAIDER	<b>Art Unit</b> 3627

SEARCHED			
Class	Subclass	Date	Examiner
705	26	6/15/08	FIH

SEARCH NOTES		
Search Notes	Date	Examiner
See attached Search History	6/15/08	FIH

INTERFERENCE SEARCH			
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